

LMNBSS139JZF 60V N-Channel Enhancement Mode MOSFET

Features

- $R_{DS(ON)}=2.5\Omega@V_{GS}=4.5V$
- $R_{DS(ON)}=4\Omega@V_{GS}=2.5V$
- Improved dv/dt capability
- Fast switching
- ESD Protected: 1500V

These devices are well suited for high efficiency fast switching applications.

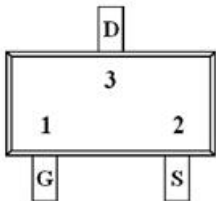
Product Description

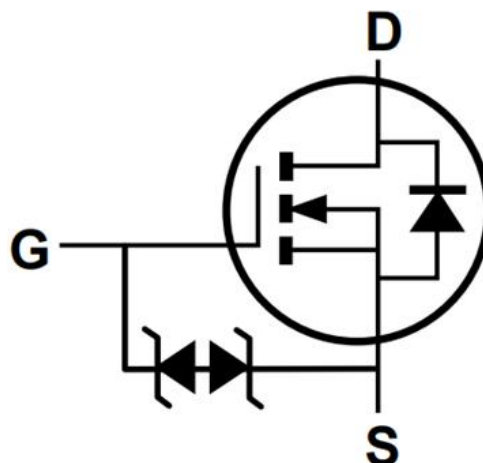
The N-Channel enhancement mode power field effect transistors is using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

Applications

- Notebook
- Load Switch
- LED applications

Pin Configuration

LMNBSS139JZF (SOT-23)	
 Top Views	
Pin	Description
1	Gate
2	Source
3	Drain



Ordering Information

Part Number	P/N	PKG Code	Pb Free Code	Package	Quantity Reel
LMNBSS139JZF	LMNBSS139	JZ	F	SOT-23	3000 pcs

Marking Information

Part Marking	Part Number	LFC code
J2 XWMM	J2	XWMM

Absolute Maximum Ratings

(T_A=25°C Unless otherwise noted)

Symbol	Parameter		Typical	Unit
V _{DSS}	Drain-Source Voltage		60	V
V _{GSS}	Gate-Source Voltage		±20	V
I _D	Continuous Drain Current	T _A =25°C	0.2	A
		T _A =70°C	0.16	
I _{DM}	Pulsed Drain Current		0.8	A
P _D	Total Power Dissipation	T _A =25°C	0.225	W
		T _A =70°C	0.14	
T _J	Operating Junction Temperature Range		-55 to +150	°C
T _{STG}	Storage Temperature Range		-55 to +150	°C
R _{θJA}	Thermal Resistance-Junction to Ambient		556	°C/W

Electrical Characteristics

(T_A=25°C Unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	60			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	0.8		1.5	V
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±20V			±10	uA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =25V, V _{GS} =0V			0.1	uA
		V _{DS} =50V, V _{GS} =0V			0.5	uA
R _{DS(on)}	Drain-Source On-Resistance	V _{GS} =4.5V, I _D =0.2A			2.5	Ω
		V _{GS} =2.5V, I _D =0.1A			4	
g _{FS}	Forward Transconductance	V _{DS} =25V, I _D =0.2A	0.1			S
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =0.5A			1.2	V
Dynamic						
C _{iss}	Input Capacitance	V _{DS} =25V, V _{GS} =0V, f=1MHz		22.8		pF
C _{oss}	Output Capacitance			3.5		
C _{rss}	Reverse Transfer Capacitance			2.9		
Q _g	Total Gate Charge	V _{DS} =25V, V _{GS} =4.5V, I _D =0.2A		0.6		nC
Q _{gs}	Gate-Source Charge			0.22		
Q _{gd}	Gate-Drain Charge			0.2		
t _{d(on)}	Turn-On Delay Time	V _{DD} =25V, I _D =0.2A, V _{GS} =10V, R _G =25Ω		3.8		ns
T _r	Turn-On Rise Time			7.5		
t _{d(off)}	Turn-Off Delay Time			19		
T _f	Turn-Off Fall Time			15		

Typical Performance Characteristics

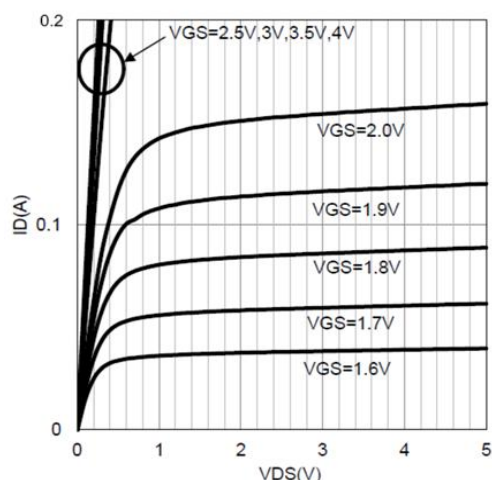


Fig.1 Typical Output Characteristics

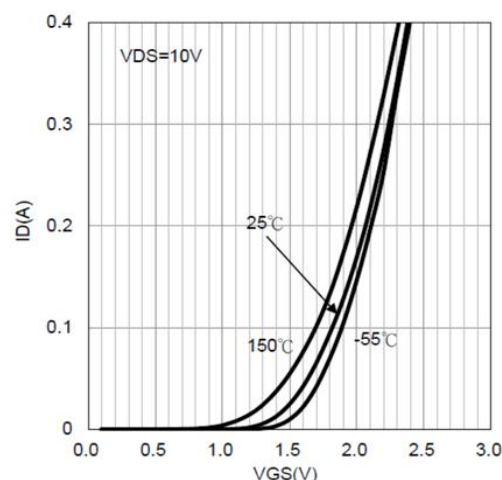


Fig.2 Typical Transfer Characteristics

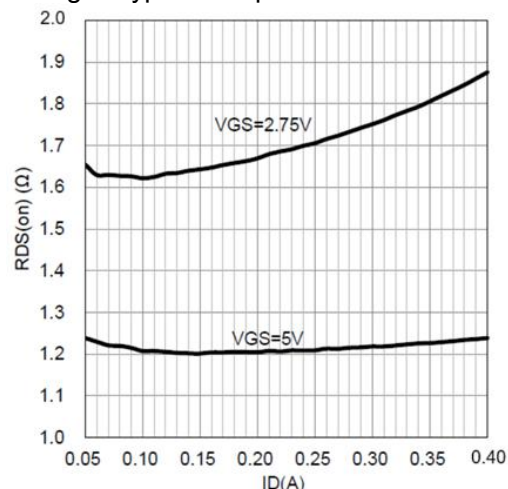


Fig.4 Typical On-Resistance vs. I_D and V_{GS}

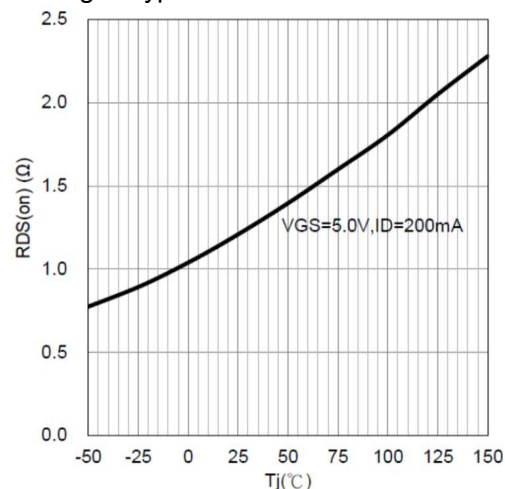


Fig.3 Typical Drain-Source On-Resistance vs. Junction Temperature

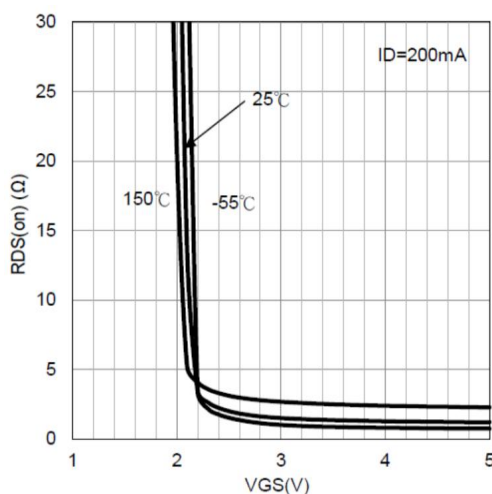


Figure 5. Drain-Source On-State Resistance vs. V_{GS}

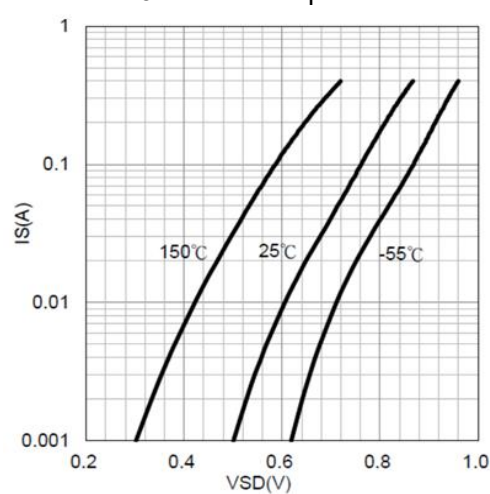


Fig. 6 Diode Forward Voltage vs. Current

Typical Performance Characteristics (continue.)

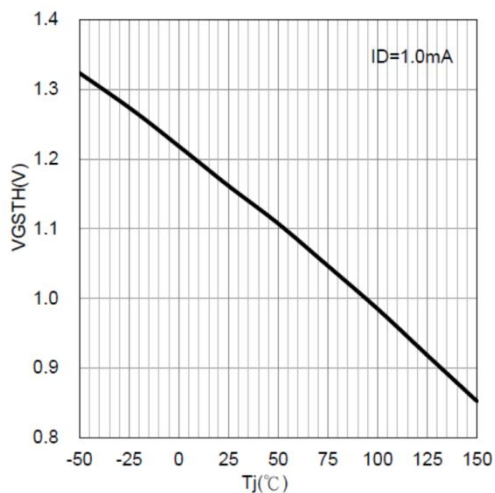


Fig.7 Gate Threshold Voltage vs. T_J

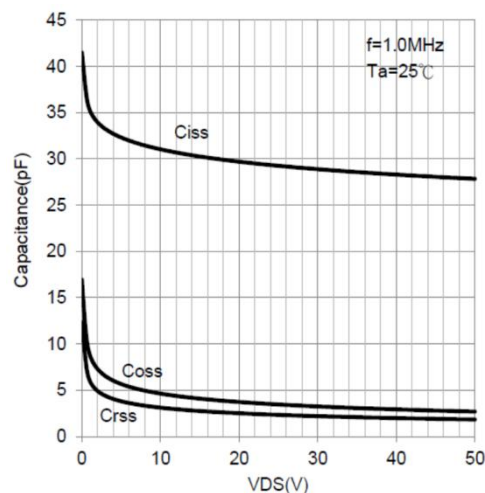


Fig.8 Capacitance vs. V_{DS}

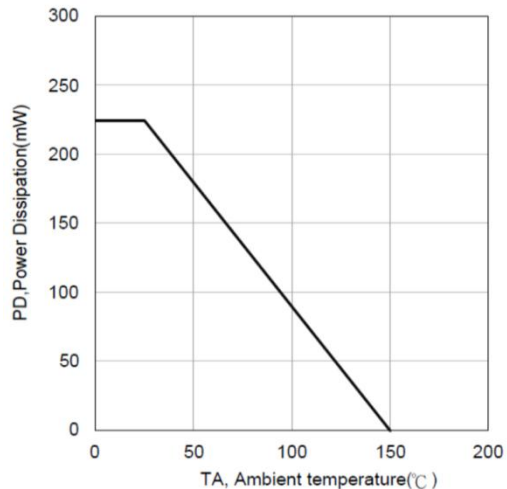
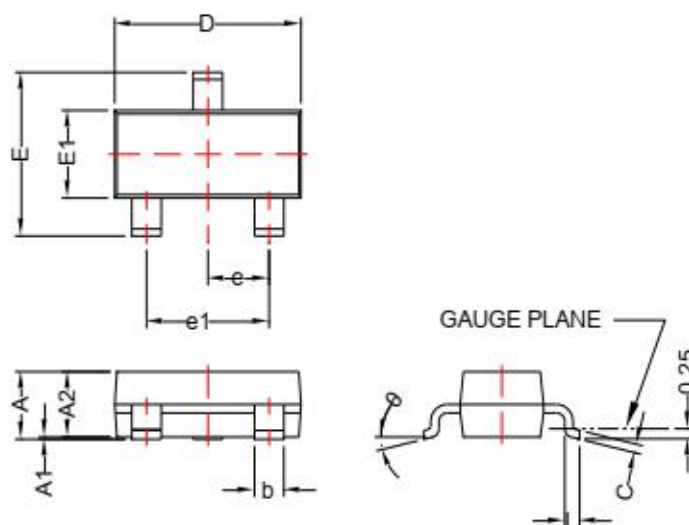


Fig.9 Power Dissipation vs. Ambient Temperature

Package Dimension
SOT-23


Dimensions				
Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	0.750	1.170	0.030	0.046
A1	0.010	0.150	0.000	0.006
A2	0.700	1.020	0.028	0.040
b	0.300	0.500	0.012	0.020
c	0.080	0.200	0.003	0.008
D	2.800	3.040	0.110	0.120
E	2.100	2.640	0.083	0.104
E1	1.200	1.400	0.047	0.055
e	0.950 BSC		0.037 BSC	
e1	1.900 BSC		0.075 BSC	
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°